

# Week 2 Homework

Probability Model and Data Analysis
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## Homework of Conditional Probability

### Question 1

With respect of Example 1.16, consider the priori probability model

$$P[rr] = 0.01, P[ra] = 0.01, P[ar] = 0.01, P[aa] = 0.97.$$

Let B denote the event that the first chip tested image rejected and similiarly, let denote A the event that the second circuit is a failure.

Find  $P[A^c|B]$  and  $P[A^c|B^c]$ 

#### Solution

From the information given by the question, we know that

$$P[A] = P[rr] + P[ar]$$

$$= 0.01 + 0.01$$

$$= 0.02$$

$$P[B] = P[rr] + P[ra]$$

$$= 0.01 + 0.01$$

$$= 0.02$$

$$P[B^c] = P[aa] + P[ar]$$

$$= 0.02$$

$$P[B^c] = P[aa] + P[ar]$$

$$= 0.97 + 0.01$$

$$= 0.98$$

$$P[A^cB] = P[ra]$$

$$= 0.01$$

$$P[A^cB] = P[aa]$$

$$= 0.97$$

$$P[A^cB] = \frac{P[A^cB^c]}{P[B^c]}$$

$$= \frac{0.01}{0.02} = \frac{1}{2} = 0.5$$

$$P[A^cB] = \frac{P[A^cB^c]}{0.98}$$

#### Question 2

Two manufacturing plants produce similar parts. Plant 1 produces 1,000 parts, 100 of which are defective. Plant 2 produces 2,000 parts, 150 of which are defective. A part is selected at random and found to be defective. What is the probability that it came from plant 1? (Hint: Let B be the event that "the part selected is defective," and let A be the event that "gthe part selected came from plant 1." Find P[A|B])

#### Solution

From the information given by the question, we know that

$$P[A] = \frac{parts\ produced\ from\ plant\ 1}{all\ part\ from\ both\ plants}$$
$$= \frac{1000}{3000}$$

$$P[B] = \frac{all \ defected \ parts}{all \ parts \ from \ both \ plants}$$
$$= \frac{250}{3000}$$

$$P[AB] = \frac{parts\ from\ plant\ 1\ and\ defected}{all\ parts\ from\ both\ plants}$$
 
$$= \frac{100}{3000}$$

$$P[A|B] = \frac{P[AB]}{P[B]}$$

$$= \frac{\frac{100}{3000}}{\frac{250}{3000}} = \frac{100}{250} = \frac{2}{5} = 0.4$$

#### Answer

... The probability of getting parts produced in plant 1 where randomly inspect where the part is defective is equal to 0.4